

VIP EXTENDED

Power Device Testing

Our Hatina WS family is now larger thanks to our newest extraordinary equipment.

The newest innovative equipment for testing power devices increasing parallelism (up to 48/96 site in single configuration)

By pairing up 4 VIP Extended, you can test up to 400 vi-power & smart power devices in parallel!

Main Features

- Up to 48 sites
- Up to 200 A
- Extremely high production rates
- Quick maintenance
- Low footprint
- Incredibly low cost per site
- Up to 3 kV
- Higher with Ping Pong configuration

Details

Automatic Test equipment for EWS, Instrip and final test for:

- High side and low side driver devices
- IGBT
- Power MOS
- Smart Power



Dimensions

Height: 350 mm
Width: 600 mm
Depth: 640 mm

Applications



CONSUMER



SPACE



AUTOMOTIVE



MEMs



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